

UNISONIC TECHNOLOGIES CO., LTD

UTT40P04 Power MOSFET

-50A, -40V P-CHANNEL POWER MOSFET

■ DESCRIPTION

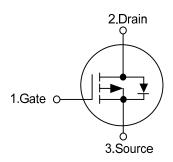
The UTC **UTT40P04** is a P-channel power MOSFET using UTC's advanced technology to provide the customers with high switching speed and a minimum on-state resistance. It can also withstand high energy in the avalanche.

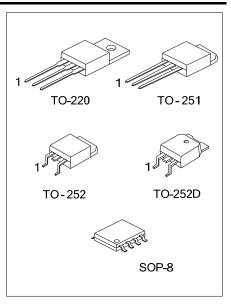
This UTC **UTT40P04** is suitable for Inverter or Power supplies.

■ FEATURES

* $R_{DS(ON)}$ < 20m Ω @ V_{GS} =-10V, I_D =-12.7A, $R_{DS(ON)}$ < 30 m Ω @ V_{GS} =-4.5V, I_D =-10.4A

■ SYMBOL

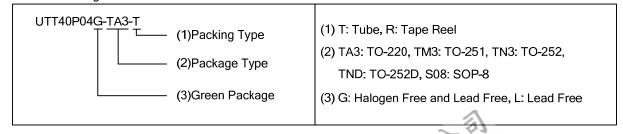




■ ORDERING INFORMATION

Ordering Number		Dealtes	Pin Assignment							Dooking	
Lead Free	Halogen Free	Package	1	2	3	4	5	6	7	8	Packing
UTT40P04L-TA3-T	UTT40P04G-TA3-T	TO-220	G	D	S	ı	ı	-	-	ı	Tube
UTT40P04L-TM3-T	UTT40P04G-TM3-T	TO-251	G	D	S	ı	ı	-	-	ı	Tube
UTT40P04L-TN3-R	UTT40P04G-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
UTT40P04L-TND-R	UTT40P04G-TND-R	TO-252D	G	D	S	-	-	-	-	-	Tape Reel
UTT40P04L-S08-R	UTT40P04G-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	-40	V	
Gate-Source Voltage		V_{GSS}	±20	V	
Drain Current	Continuous	Package limited	I _D	-50	Α
		Silicon limited		-58	Α
	Pulsed		I_{DM}	-100	Α
Single Pulsed Avalanche Energy (Note 2)		E _{AS}	337	mJ	
Power Dissipation	T _C =25°C	TO-220	P _D	125	W
		TO-251/TO-252 TO-252D		55	W
		SOP-8		3.4	W
	T _A =25°C	TO-220		2	W
		TO-251/TO-252 TO-252D		1.1	W
		SOP-8		1.6	W
Junction Temperature		T_J	-55 ~ +150	°C	
Storage Temperature		T_{STG}	-55 ~ + 150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
	TO-220		62.5	°C/W
Junction to Ambient	TO-251/TO-252 TO-252D	θ_{JA}	110	°C/W
	SOP-8		75 (Note)	°C/W
	TO-220		1	°C/W
Junction to Case	TO-251/TO-252 TO-252D	θ_{JC}	2.27	°C/W
	SOP-8		36.7	°C/W

Note: The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.



^{2.} Starting T_J = 25°C, L = 3mH, I_{AS} = 15A, V_{DD} = 40V, V_{GS} = 10V.

ELECTRICAL CHARACTERISTICS (T_J=25°C, unless otherwise specified)

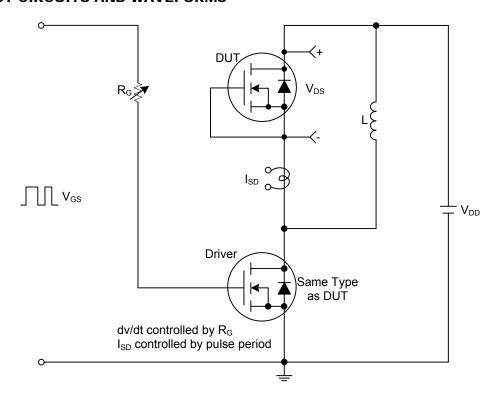
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	I_D =-250 μ A, V_{GS} =0V	-40			V
Drain-Source Leakage Current	I_{DSS}	V _{DS} =-32V, V _{GS} =0V			-1	μΑ
Gate- Source Leakage Current	I _{GSS}	V_{GS} =+20V, V_{DS} =0V			+100	nA
Reverse		V _{GS} =-20V, V _{DS} =0V			-100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=-250\mu A$	-1	-1.8	-3	V
Static Drain-Source On-State Resistance	e R _{DS(ON)}	V _{GS} =-10V, I _D =-12.7A		17	20	mΩ
Static Dialii-Source Oil-State Resistance		V _{GS} =-4.5V, I _D =-10.4A		24	30	mΩ
DYNAMIC PARAMETERS						
Input Capacitance	C_{ISS}			2085	2775	рF
Output Capacitance	Coss	V_{GS} =0V, V_{DS} =-20V, f=1.0MHz		360	480	pF
Reverse Transfer Capacitance	C_{RSS}			210	310	pF
Gate Resistance	R_{G}	f=1.0MHz		4.6		Ω
SWITCHING PARAMETERS	_			a		
	Q_{G}	V _{GS} =0~-10V, V _{DD} =-20V,		230		nC
Total Gate Charge		I _D =-12.7A		230		110
Total Gate Griange		V _{GS} =0~-5V, V _{DD} =-20V,		120		nC
		I _D =-12.7A		120		110
Gate to Source Charge	Q_GS	V _{DD} =-20V, I _D =-12.7A		17		nC
Gate to Drain Charge	Q_GD	V _{DD} =-20V, I _D =-12.7A		21		nC
Turn-ON Delay Time	$t_{D(ON)}$			36		ns
Rise Time	t_R	V_{DD} =-20V, I_{D} =-12.7A, R_{GEN} =6 Ω ,		76		ns
Turn-OFF Delay Time	t _{D(OFF)}	V _{GS} =-10V		600		ns
Fall-Time	t_{F}			380		ns
SOURCE- DRAIN DIODE RATINGS AND	CHARACTE	RISTICS				
Drain-Source Diode Forward Voltage	V_{SD}	I _S =-12.7A, V _{GS} =0V (Note 1)		-0.8	-1.2	V
Body Diode Reverse Recovery Time	t _{rr}	L= 12.7A di/dt=100A/up		29	44	ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F =-12.7A, di/dt=100A/μs		26	40	μC

Notes: 1. Pulse Test: Pulse Width < $300\mu s$, Duty cycle < 2.0%.

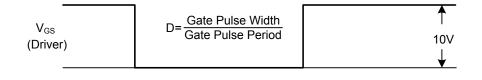
2. Starting T_J = 25°C, L = 3mH, I_{AS} = 15A, V_{DD} = 40V, V_{GS} = 10V.

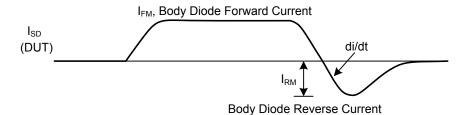


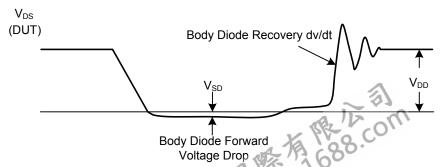
■ TEST CIRCUITS AND WAVEFORMS



Peak Diode Recovery dv/dt Test Circuit



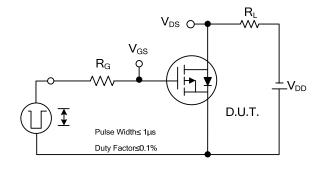


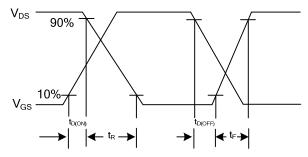


Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

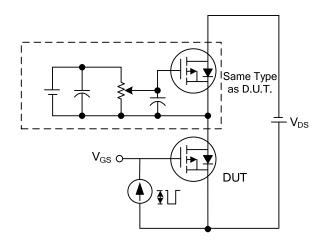
TEST CIRCUITS AND WAVEFORMS

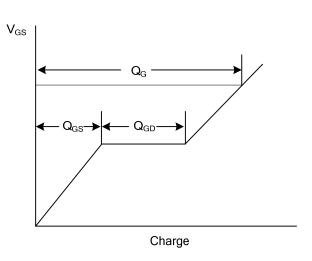




Switching Test Circuit

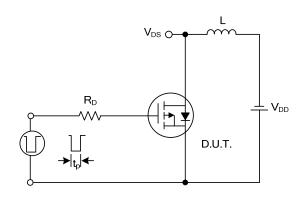
Switching Waveforms

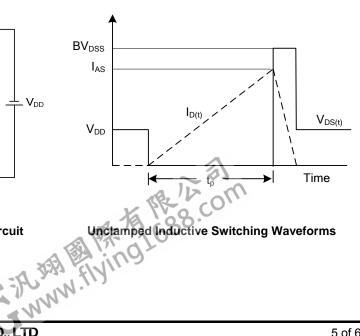




Gate Charge Test Circuit

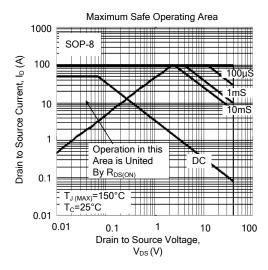
Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

■ TYPICAL CHARACTERISTICS



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